



80

N-Channel 80-V (D-S) Super Junction Power MOSFET

82 nC

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}$ (m Ω)(Typ.)	I _D (A) ^a	Q _g (Typ.)	

198

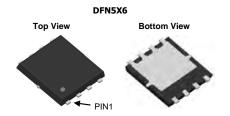
FEATURES

- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested

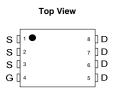


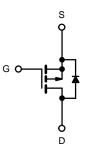
APPLICATIONS

- High-Efficiency DC-DC Converters
- Motor Drivers



1.9 at $V_{GS} = 10 \text{ V}$





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unles	ss otherwise note	ed		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	80	V	
Gate-Source Voltage	V_{GS}	± 20	7		
	T _C = 25 °C		198 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	$T_C = 70 ^{\circ}C$	I _D	146 ^a		
Commission Plant Carrotte (1) = 100 °C)	T _A = 25 °C	.U	32 ^{b, c}		
	T _A = 70 °C		26 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	690	^	
Continuous Source-Drain Diode Current	$T_C = 25 ^{\circ}C$ $T_A = 25 ^{\circ}C$	I _S	190 ^a		
Continuous Source-Drain Diode Current		'5	32 ^{b, c}		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	165		
Single Pulse Avalanche Energy		E _{AS}	853	mJ	
	T _C = 25 °C		215		
Maximum Power Dissipation	T _C = 70 °C	P _D	137.6	W	
Maximum Fower Dissipation	T _A = 25 °C	, n	3.75 ^{b, c}	VV	
	T _A = 70 °C		2.3 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 10 s	R _{thJA}	25	45	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	0.6	0.75]	

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The DFN5x6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 54 °C/W.





Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						<u> </u>	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	80			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	$\Delta V_{DS}/T_J$ $I_D = 250 \mu A$		35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1D = 230 μΛ		- 6.5		mv/·C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 1 \text{ mA}$	2.5		3.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$			1		
		$V_{DS} = 64 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} = 5 \text{ V}, V_{GS} = 10 \text{ V}$	198			Α	
Drain-Source On-State Resistance ^a	D	V _{GS} = 10 V, I _D = 20 A		1.9	2.6		
	R _{DS(on)}	$V_{GS} = 6 \text{ V}, I_D = 20 \text{ A}$		2.5	3.5	mΩ	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 5 V, I _D = 20 A		96		S	
Dynamic ^b							
Input Capacitance	C _{iss}			8050		pF	
Output Capacitance	C _{oss}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		1426			
Reverse Transfer Capacitance	C _{rss}			62			
Total Gate Charge	Qg			82			
Gate-Source Charge	Q _{gs}	$V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		20		nC	
Gate-Drain Charge	Q_{gd}			18			
Gate Resistance	R_g	f = 1 MHz		2		Ω	
Turn-On Delay Time	t _{d(on)}			15			
Rise Time	t _r	V_{DD} = 40 V, R_L = 1 Ω		39		ns	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 20~A,~V_{GEN}=10~V,~R_g=5~\Omega$		40			
Fall Time	t _f			157			
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			198	Α	
Pulse Diode Forward Current ^a	I _{SM}				690	^	
Body Diode Voltage	V_{SD}	I _S = 1 A		0.6	1.0	V	
Body Diode Reverse Recovery Time	t _{rr}			50		ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, dI/dt = 100 A/μs, T _J = 25 °C		75		nC	
Reverse Recovery Fall Time	t _a	1F = 20 A, α//αι = 100 A/μs, 1J = 25 C		26		nc	
Reverse Recovery Rise Time	t _b			24		ns	

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

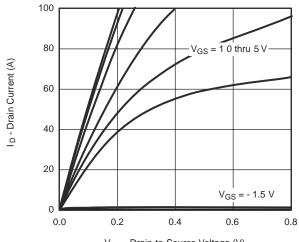
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.



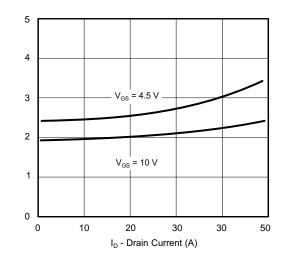
R_{DS(on)} - On-Resistance (mΩ)

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

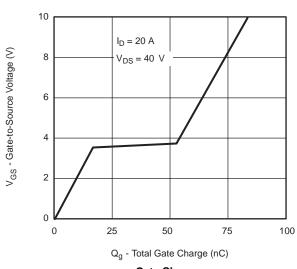


 $V_{\mbox{\scriptsize DS}}$ - Drain-to-Source Voltage (V)

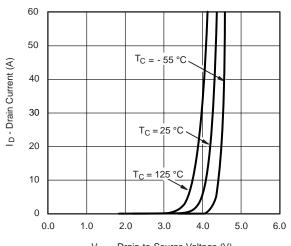




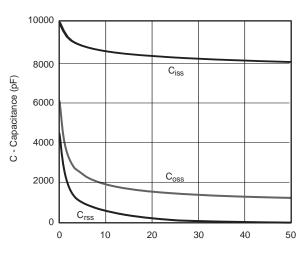
On-Resistance vs. Drain Current and Gate Voltage



Gate Charge

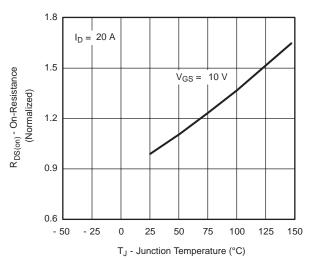


V_{DS} - Drain-to-Source Voltage (V) **Transfer Characteristics**



 V_{DS} - Drain-to-Source Voltage (V)





On-Resistance vs. Junction Temperature

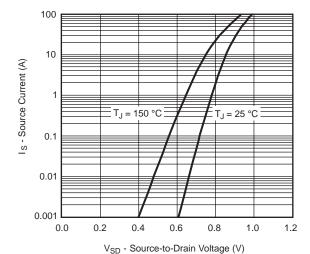
 $T_J = 125$ °C

 $T_J = 25 \, ^{\circ}C$

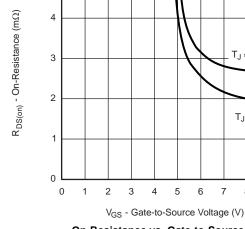
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



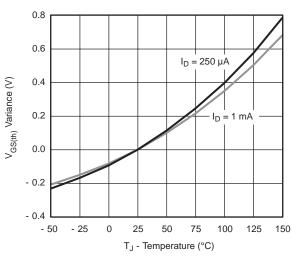
Source-Drain Diode Forward Voltage



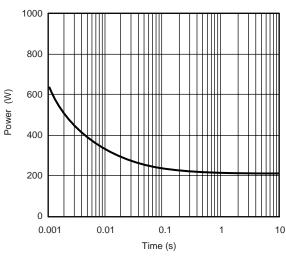
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On-Resistance vs. Gate-to-Source Voltage

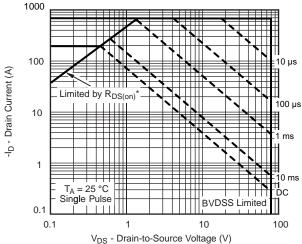
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Threshold Voltage



Single Pulse Power, Junction-to-Ambient

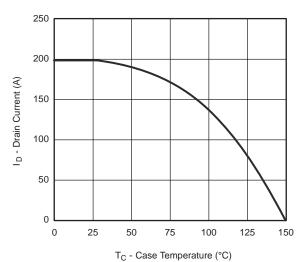


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

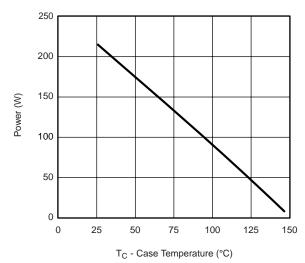


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

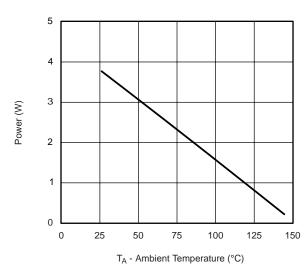


Current Deretines*

Current Derating*





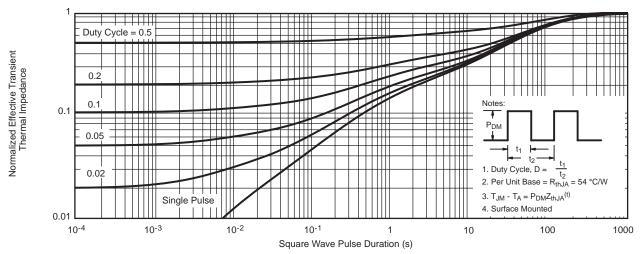


Power, Junction-to-Ambient

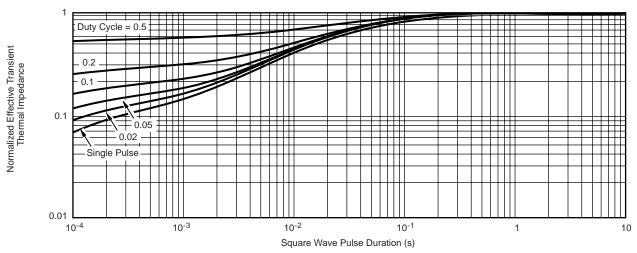
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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